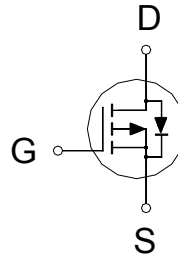


PRODUCT SUMMARY

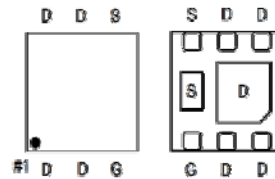
$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
-30V	25m Ω	-8A


Features

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.

Applications

- Protection Circuits Applications.
- Logic/Load Switch Circuits Applications.



G : GATE
D : DRAIN
S : SOURCE

ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	-30	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	$T_A = 25\text{ }^{\circ}\text{C}$	I_D	-8	A
	$T_A = 70\text{ }^{\circ}\text{C}$		-6.4	
Pulsed Drain Current ¹		I_{DM}	30	
Power Dissipation ³	$T_A = 25\text{ }^{\circ}\text{C}$	P_D	2.7	W
	$T_A = 70\text{ }^{\circ}\text{C}$		1.7	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	$^{\circ}\text{C}$

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE		SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$t \leq 10\text{ s}$	$R_{\theta JA}$		45	$^{\circ}\text{C}/\text{W}$
Junction-to-Ambient ²	Steady-State	$R_{\theta JA}$		65	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^{\circ}\text{C}$.

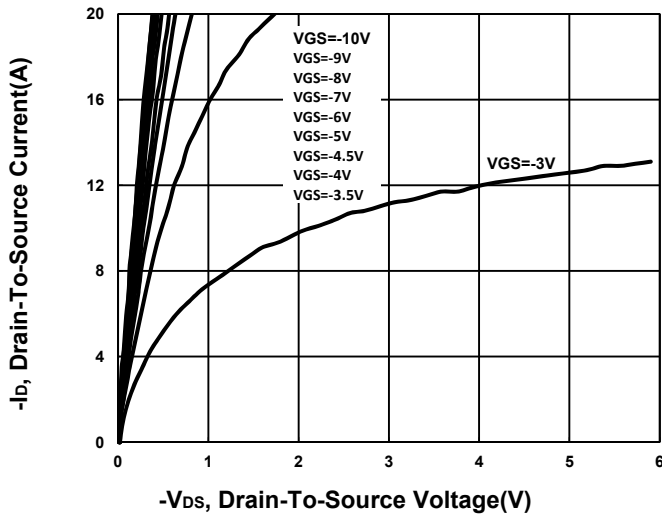
³The Power dissipation is based on $R_{\theta JA}$ $t \leq 10\text{ s}$ value.

ELECTRICAL CHARACTERISTICS ($T_J = 25\text{ }^{\circ}\text{C}$, Unless Otherwise Noted)

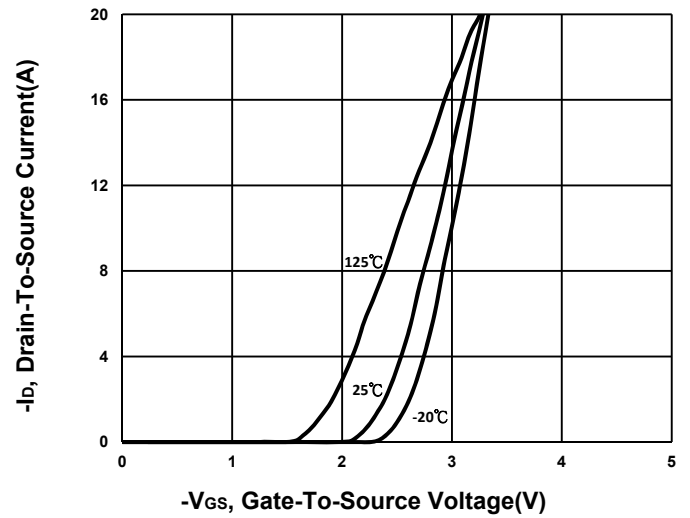
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = -250\mu A$	-30			V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = -250\mu A$	-0.8	-1.7	-2.5	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -24V, V_{GS} = 0V$			-1	μA
		$V_{DS} = -20V, V_{GS} = 0V, T_J = 55\text{ }^{\circ}C$			-10	
Drain-Source On-State Resistance ¹	$R_{DS(ON)}$	$V_{GS} = -10V, I_D = -6A$		18	25	m Ω
		$V_{GS} = -4.5V, I_D = -6A$		29	40	
Forward Transconductance ¹	g_{fs}	$V_{DS} = -5V, I_D = -6A$		22		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = -15V, f = 1MHz$		920		pF
Output Capacitance	C_{oss}			133		
Reverse Transfer Capacitance	C_{rss}			115		
Gate Resistance	R_g	$V_{GS} = 0V, V_{DS} = 0V, f = 1MHz$		13		Ω
Total Gate Charge ²	$Q_{g(VGS=-10V)}$	$V_{DS} = -15V, I_D = -6A$		20		nC
	$Q_{g(VGS=-4.5V)}$			10		
Gate-Source Charge ²	Q_{gs}			2		
Gate-Drain Charge ²	Q_{gd}			5		
Turn-On Delay Time ²	$t_{d(on)}$	$V_{DD} = -15V$ $I_D \cong -6A, V_{GEN} = -10V, R_G = 6\Omega$		16		nS
Rise Time ²	t_r			18		
Turn-Off Delay Time ²	$t_{d(off)}$			40		
Fall Time ²	t_f			26		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25\text{ }^{\circ}C$)						
Continuous Current	I_S				-2.7	A
Forward Voltage ¹	V_{SD}	$I_F = -6A, V_{GS} = 0V$			-1	V
Reverse Recovery Time	t_{rr}	$I_F = -6A, di_F/dt = 100A / \mu S$		11		nS
Reverse Recovery Charge	Q_{rr}			3.8		nC

¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.

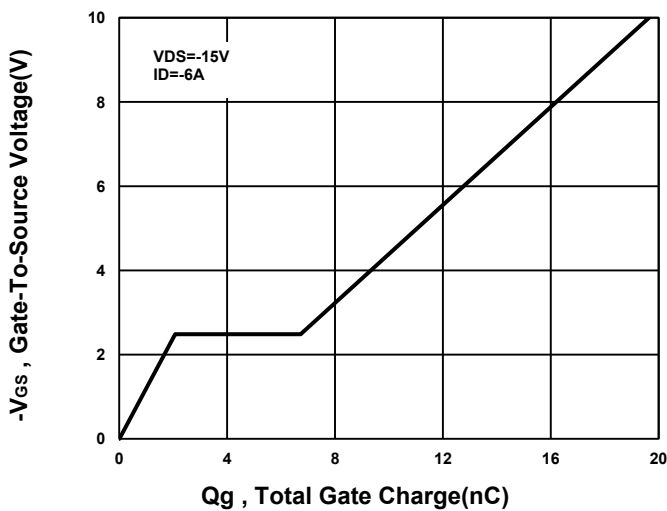
Output Characteristics



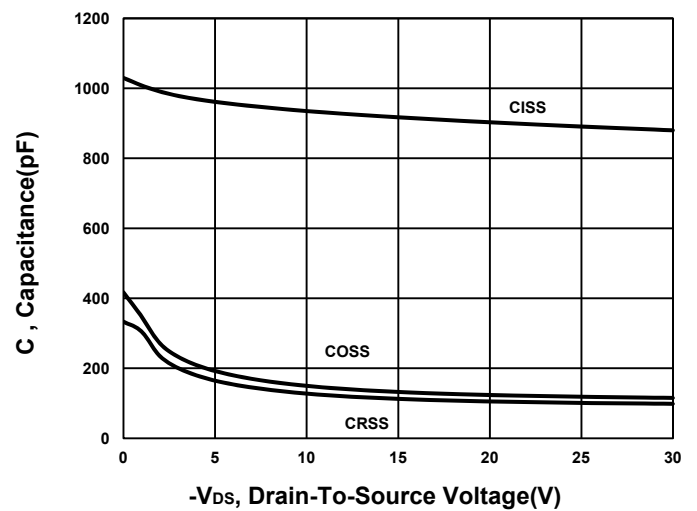
Transfer Characteristics



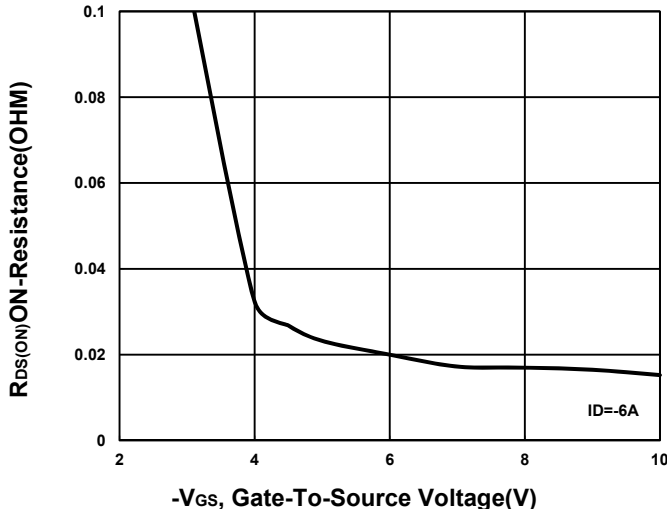
Gate charge Characteristics



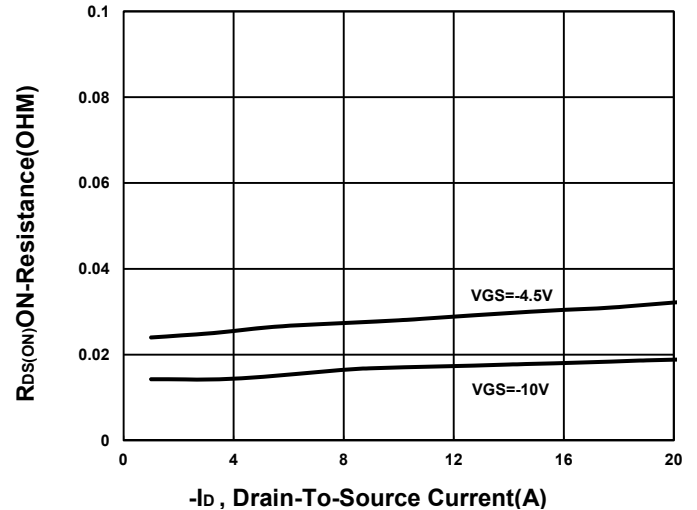
Capacitance Characteristic



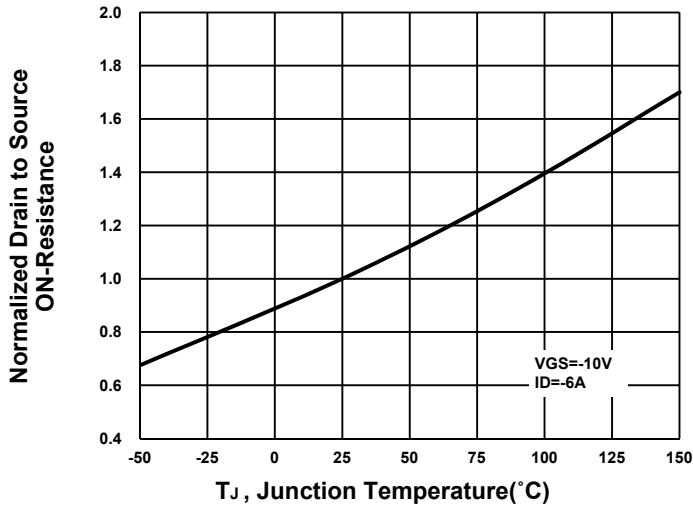
On-Resistance VS Gate-To-Source



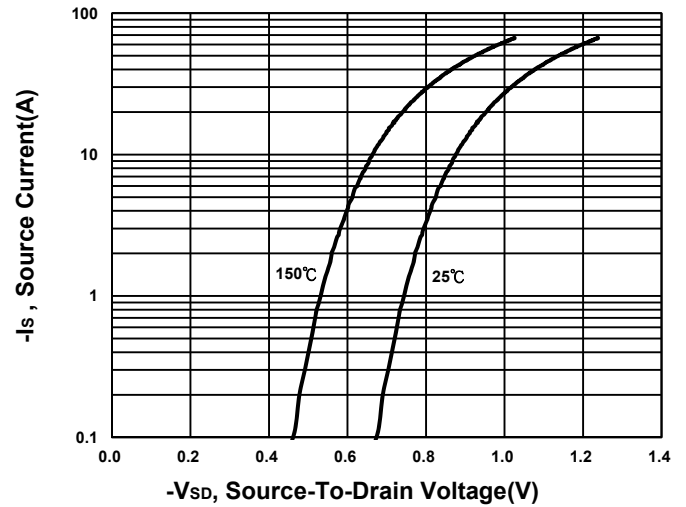
On-Resistance VS Drain Current



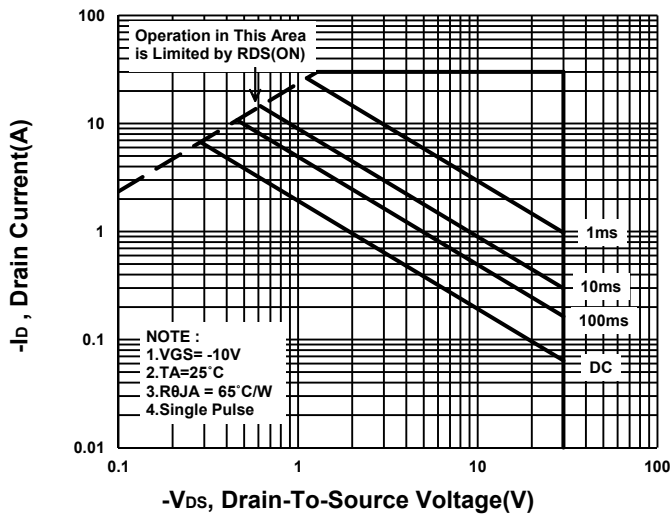
On-Resistance VS Temperature



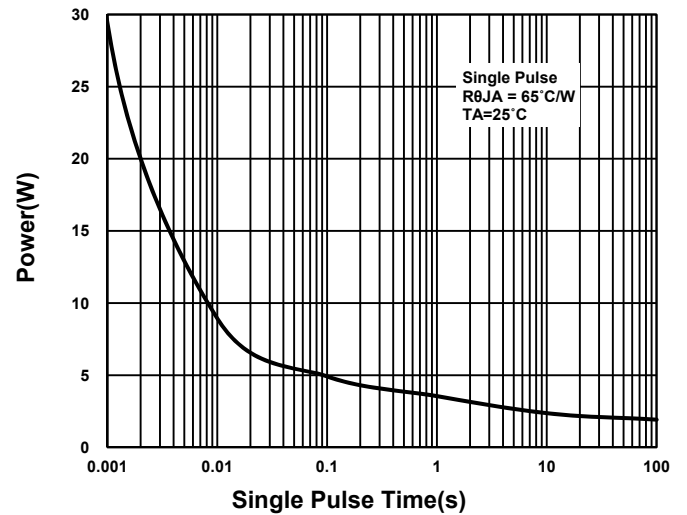
Source-Drain Diode Forward Voltage



Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

